

Design and Analysis of Low Power, High Speed 3-2 Compressor Architectures in 45-nm Technology

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Abstract---In this paper, various types of 3-2 compressor architectures have been designed and analysed. The required XOR and XNOR gate circuits have been constructed with pass transistor logic and mixed threshold voltage (MVT) as well as swing restoration technique adoption that achieves low power with less number of transistor counts i.e. lower on chip area. The proposed compressor architectures are compared with the conventional CMOS configuration and 18T. The performances of the hybrid compressor architectures compared with MVT and swing restoration is found to be more efficient in the sphere of area, power as well as performance. The simulation of the proposed designs has been performed in Cadence Virtuoso with 1 V supply.

Keywords---Mixed threshold voltage (MVT) scheme, threshold voltage, low power, high speed, power delay product (PDP), Topology (T).

I. INTRODUCTION

The present research interests in growing mobility and performance of small portable mobile devices, three important areas i.e. speed, area and power consumption are specially highlighted where speed has become one of the most serious issue in modern VLSI design as well as the leakage power reduction.

In respect to the multiplication algorithm, parallel multipliers are widely used to speed up the processors in respect to performance. Compared to the serial multipliers [1]. There are two basic directions to improve the performance of the parallel multipliers, one is the Booth algorithm and the other is the Wallace tree compressors [2]. A basic Multiplier architecture concept can be separated into three parts, (1) partial product generation, (2) partial product accumulation stage and (3) final addition stage for getting the output.

During the partial products accumulation stage in multipliers, large amount of power and delay are required as the higher order accumulation program demands higher order compressor circuit. More number of adders or

compressors are involved to perform the partial product accumulation as higher order multiplications circuits demands more no. of full adder and compressor circuits [3-4]. The numbers of adders are reduced simply by adopting different methodologies of higher order compressors in the complex multipliers. A basic 3-2 Compressor circuit is based on the concept of the counter of full adder. A higher order compressors circuit have four/five/six/seven inputs and two outputs as a basic 3-2 Compressor circuitry may be expressed as a one bit full adder circuit [5]. The speed, area and power consumption of the multipliers are directly proportional to the efficiency of the compressor circuitry [6-7].

A basic 3-2 Compressor is defined as a single bit adder circuit that has three inputs as in full adder and two outputs. The proposed hybrid architectures (shown in section 4) contain the fact that both the XOR and XNOR logic are efficiently used to reduce the delay. To reduce the power consumption by using MVT and to improve the output swing by introducing swing restoration circuit are adopted in this work. The high V_t transistors are placed such a way that they are not in the critical path. Thus the time required for switching of the p-mos. and n-mos. transistors in the critical path is not extended.

II. MIXED THRESHOLD VOLTAGE (MVT)

In the case of mixed- V_{th} CMOS circuit, there can have various threshold voltages with definite process suppress the transistors in the gates inside the transistors. There we take into account, two types of mixed- V_{th} CMOS circuit intention. For type one scheme (MVT1), there is neither any mixed V_{th} in pull-up nor in pull-down networks. For the other scheme (MVT2), mixed V_{th} is permitted everywhere apart from the transistors connected in series as the transistors remaining in stack have the same threshold voltage is just because of the system estimation. As the threshold voltage of a transistor is dominated by

channel doping methodology, the transistors having stack, the channels remain very intimate to each other which makes it very difficult to acquire exclusive channel doping. Hence, it is inflexible for getting separate threshold voltages for the transistors having stack. Audibly, multi-threshold-voltage scheme offers more benefits for the high threshold action in CMOS circuits than the gate-level dual threshold voltage (Dual V_{th}) concept.[8]- [9]

III. PROPOSED DIFFERENT COMPRESSOR ARCHITECTURES (3-2)

The 3-2 compressor consists 3 inputs (x₁, x₂ and cin) and 2 outputs (Sum & Carry) i.e. a full adder. The input Cin is the output from the neighbouring lower significant compressor circuit. The combination of more 3-2 compressors construct higher order compressors as 3-2 is the basic building block of compressor shown in Fig.1. The Boolean expressions of a basic 3-2 compressor are as expressed below:

$$\text{SUM out} = A \oplus B \oplus \text{Cin}$$

$$\text{CARRY out} = (A \oplus B) \cdot \text{Cin} + (A \odot B) \cdot B$$

This work focuses on various types of 3-2 compressor topology.

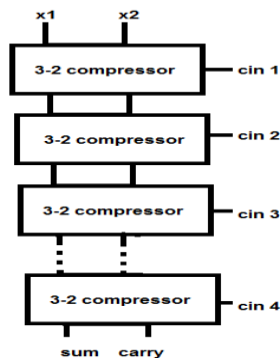


Fig. 1: Higher order compressor using 3-2 compressors.

A. Topology-1: 12T Architecture

A novel 12T 3-2 compressor has been presented here consisting 6 transistor XOR-XNOR circuitry for sum generation and pass transistor logics to form the carry shown Fig.2. Though the output of the sum delivers full output voltage swing but the output voltage of carry suffers from one threshold voltage drop i.e. VDD-V_{tn} as we have n-mos. pass transistors to form the carry which is non-ideal. This hybrid circuitry also suffers from static leakage power and overall power consumption but it has a strong impact on delay.

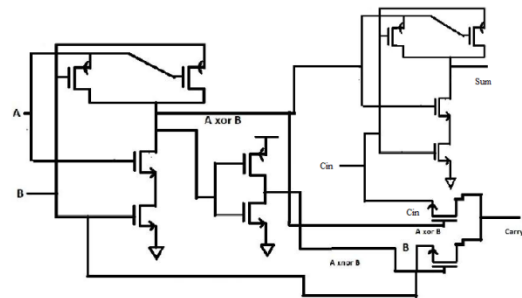


Fig. 2: Topology-1: 12T Architecture

B. Topology-2: 12T Architecture with MVT

Mixed threshold voltage concept has been adopted here to reduce the overall power consumption and the leakage power shown in Fig.3. The high V_t transistors are exchanged with some low V_t transistors such a way, the previous critical path value doesn't hamper. Thus, the delay of the topology remains same as the previous topology delivers a compatible delay.

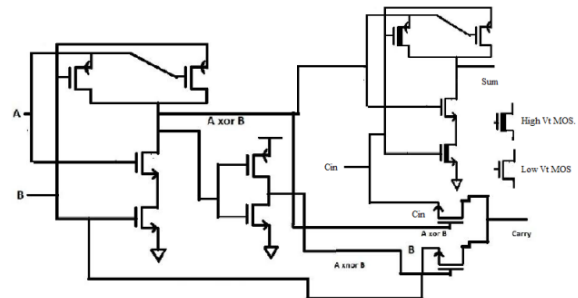


Fig. 3: Topology-2: 12T Architecture with MVT

C. Topology-3: Swing Restoration Architecture

Though topology-1 delivers a favourable delay, there remains a very extensive problem in regard to output voltage swing in the carry output caused by the n-mos. pass transistor.

This problem can be solved by adding a swing restoration circuit instead of n-mos. pass transistors shown in Fig.4.

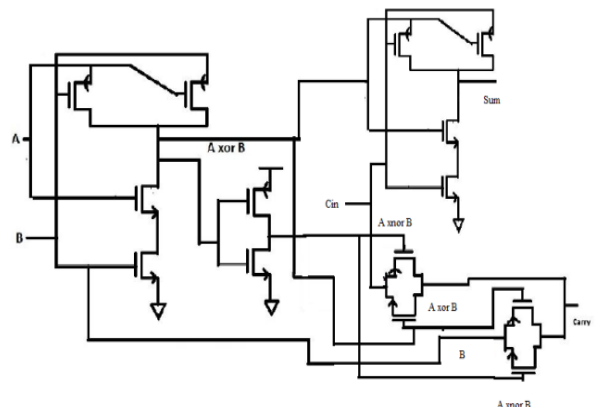


Fig. 4: Topology-3: 14T Architecture

D. Topology-4 Swing Restoration Architecture with MVT scheme.

In this new hybrid topology, delay as well as power related issues are made cleared as Topology-3 suffers from leakage power which is a big issue in deep submicron technologies by introducing MVT scheme in 14T (3-2 compressor) swing restoration topology shown in Fig.5.

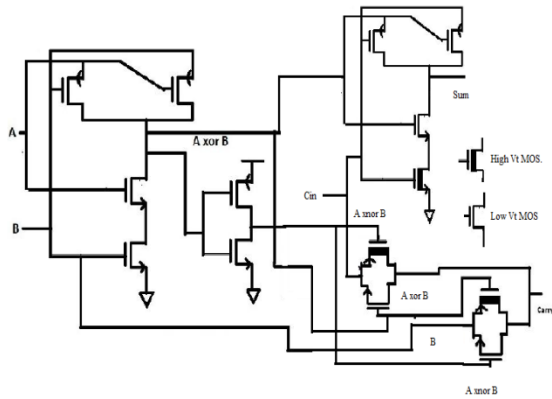


Fig. 5: Topology-4 14T Architecture with MVT scheme.

IV. SIMULATION, PERFORMANCE ANALYZE AND RESULTS

The different compressor topologies have been simulated in Cadence Virtuoso platform using 45 nm Standard CMOS process technology. The circuit schematics are converted to respective layouts (shown in Fig.6, Fig.7, Fig.8 and Fig.9) with the help of Cadence LAYOUT XL window. The parasitic extraction has been performed to realize the post layout simulation. Both pre-layout and post layout simulations have been done under 1 volt power supply.

Here T1, T2, T3 and T4 stand for Topology 1, Topology 2, Topology 3 and Topology 4 respectively.

Table: 1 put forth on the topologies in terms of compactness and smaller on chip area.

Table: 1		
TOPOLOGY	TRANSISTOR COUNT	AREA (in micron sq)
T1	12	13.694
T2	12	13.714
T3	14	14.632
T4	14	14.739

Table: 2 Different topologies in terms of smaller delay.

Table: 2		
TOPOLOGY	PRE-LAYOUT (In Pico Sec.)	POST-LAYOUT (In Pico Sec.)
T1	97.53	94.21
T2	98.62	96.38
T3	97.89	94.55
T4	98.21	96.43

Table: 3 put forth on the topologies in terms of leakage power consumption.

Table: 3		
TOPOLOGY	PRE-LAYOUT (Pico watt.)	POST-LAYOUT (Pico watt.)
T1	10.18	11.32
T2	6.26	7.18
T3	11.23	12.5
T4	7.44	8.6

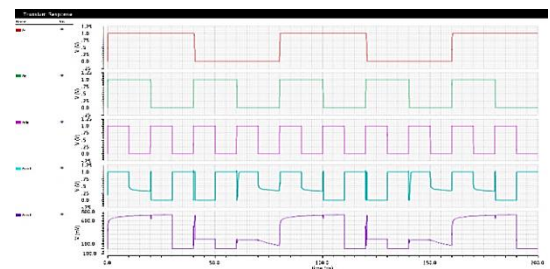
Table: 4 Average power consumption of different topologies.

Table: 4		
TOPOLOGY	PRE-LAYOUT In Nano watt.	POST-LAYOUT In Nano watt.
T1	139.6	189.1
T2	116.5	138.9
T3	154.6	178.5
T4	112.6	136.04

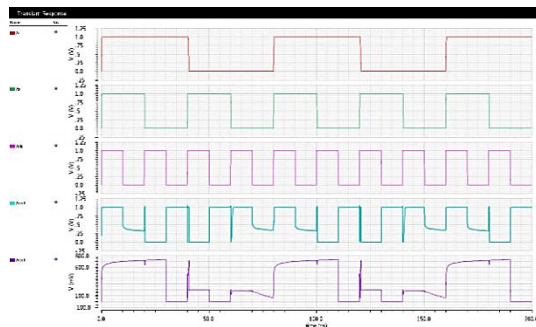
Table: 5 Power delay product of different of topologies.

Table: 5		
TOPOLOGY	PRE-LAYOUT In (WATT-SEC)	POST-LAYOUT In (WATT-SEC)
T1	13.6×10^{-18}	17.8×10^{-18}
T2	11.5×10^{-18}	13.4×10^{-18}
T3	15.5×10^{-18}	16.8×10^{-18}
T4	11×10^{-18}	13.1×10^{-18}

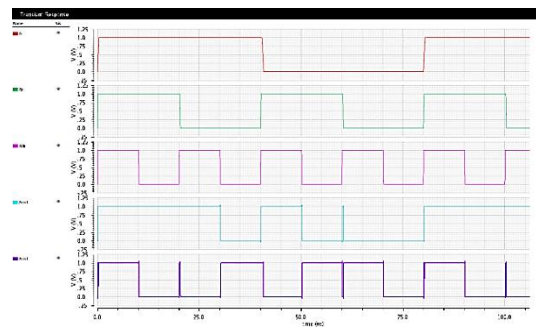
Though, all the topologies are more performance, area and power efficient than the conventional CMOS [10] and 18T [11] topologies shown in Table: 6. But there is a big issue in Topology 1 and 3 regarding output voltage swing as shown in Graph 1 and Graph 3. There is also a big issue of leakage power in topology 1 and 2 shown in Graph 1 and Graph 3 because of lower threshold voltages and short channel devices. As far it is shown that Topology 4 provides significantly less leakage power as mixed threshold voltage is applied, full output swing as swing restoration circuit replaces the pass transistors, reduced dynamic power as the issues like short circuit power dissipation is reduced due to increase of threshold voltage and lesser delay as the MVT has not been used in critical path. The power-delay products of the post layout simulations are plotted against various temperatures in Graph 6.



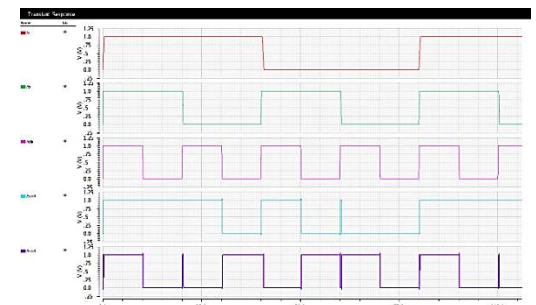
Graph 1: Output of topology 1



Graph 2: Output of topology 2



Graph 3: Output of topology 3



Graph 4: Output of topology 4

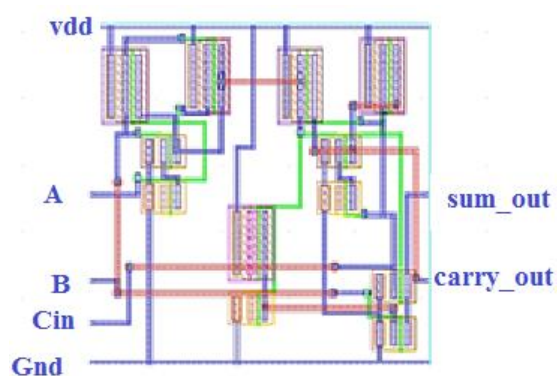


Fig: 6: layout of Topology 1

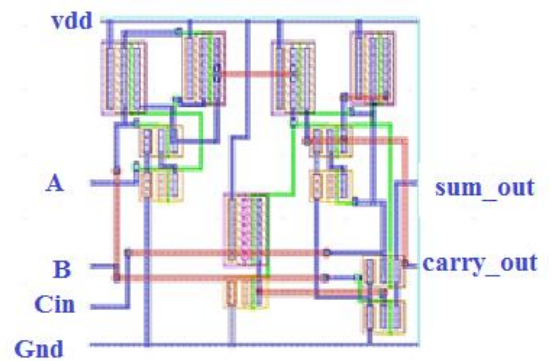


Fig: 7: layout of Topology 2

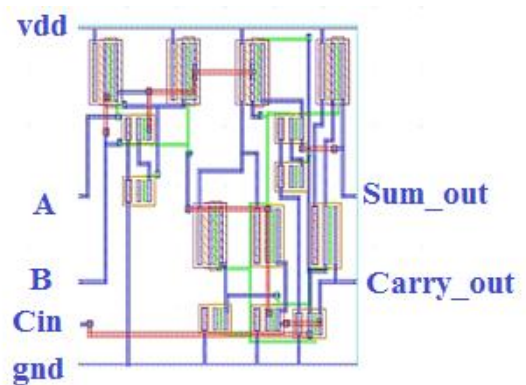


Fig: 8: layout of Topology 3

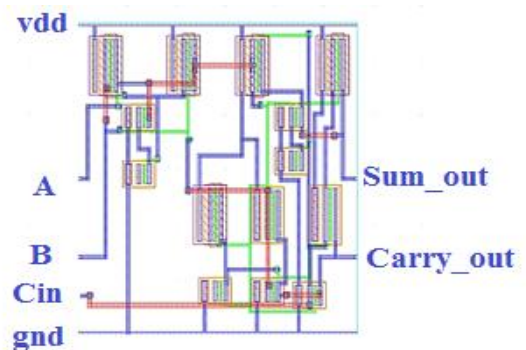
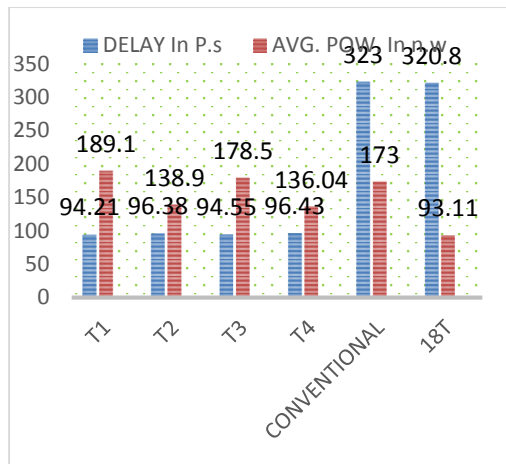


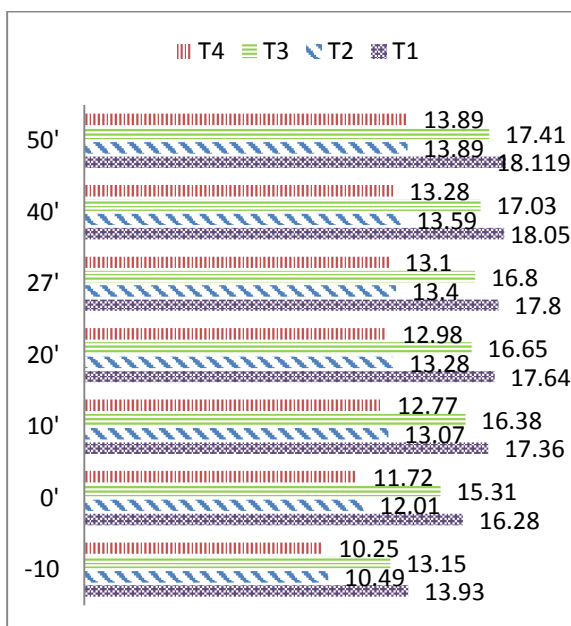
Fig: 9: layout of Topology 4

Table: 6 put forth on the topologies in terms of power and delay compared to CMOS and 18T.

Table: 6		
TOPOLOGY	<i>Propagation Delay (Pico Sec.)</i>	<i>Power consumption (Nano Watt.)</i>
Conventional [10]	323	173
18T [11]	320.8	93.11
T1	94.21	189.1
T2	96.38	138.9
T3	94.55	178.5
T4	96.43	136.04



Graph 5: Comparison of Delay and Power dissipation in various adder topologies.



Graph 6: Comparison of power-delay product (in Nano. Watt. Nano Sec) of different topologies product in various temperatures.

VII. CONCLUSIONS

This paper proposes 4 new topologies of 3:2 compressor which blooms with lesser on chip area, lesser power consumption and lesser delay. The simulation results claim the effectiveness of the proposed hybrid topologies. Also the comparative study presented in Table: 6 and Graph. 5 prove that the topologies can be efficient choice for low power high speed higher compressor design.

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